Used in Lleu of PTO/SB/08A/B (Based on PTO 04-07 version)

Substitute for form 1449/PTO				Complete if Known		
				Application Number	10/079,286	
IN	NFORMATIO:	N DI	SCLOSURE	Filing Date	February 20, 2002	
S	TATEMENT	BY A	APPLICANT	First Named Inventor	Peter R. Jepson	
				Art Unit	1742	
	(Use as many si	he ets as	necessary)	Examiner Name	L. L. Zheng	
Sheet	1	of	1	Attorney Docket Number	13194-00163-US	

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Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Initials*	Cite No.1	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (<i>ft known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	70
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. *CITE NO.: Those application(s) which are marked with an single asterisk (*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. *Applicant's unique citation designation number (options). *I see Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. *I Enter Office that issued the document, by the two-letter code (VMPO Standard ST.3). *For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. *S Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. *Applicant is to place a check mark here if English language Transistion is attached.

NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journ al, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Tº		
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^{*}EXAMINER: Initial if reference considered, whother or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant,

Examiner		Date	07/04/0007
Signature	/Lois Zheng/	Considered	07/31/2007
[Olginataro]		Considered	

^{&#}x27;Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.